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Application/Control No.	Applicant(s)/Patent under Reexamination
10/561,101	SMITH ET AL.
Examiner	Art Unit
Erich A. Leeser	1624

	SEARCHED				
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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EAST 544/358, 392, 395; 514/252.12 & 255.03 see printout		9/19/2007	EL	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
PALM inventor search	9/19/2007	EL
STN structure search	9/18/2007	EL
EAST 544/358, 392, 395; 514/252.12 & 255.03 with search terms, see printout	9/19/2007	EL